## Application/Control No. Applicant(s)/Patent Under Reexamination 10/618,635 MOELLER ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2644 Devona E. Faulk **U.S. PATENT DOCUMENTS** Date **Document Number** Classification Name Country Code-Number-Kind Code MM-YYYY 381/73.1 03-1982 Orfield, Steven J. US-4,319,088 Α \* 381/73.1 US-4,686,693 08-1987 Ritter, David W. В 381/98 \* US-4,612,665 09-1986 Inami et al. С US-D US-Ε US-F US-G USн US-US-USĸ US-L US-М **FOREIGN PATENT DOCUMENTS Document Number** Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U w

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